





Transforming Motor Winding Testing

NEW

IEC standard-compliant testing

Streamline PDIV and PDEV measurement

Automatically display results simply by setting the starting voltage, maximum voltage, and voltage step width (requires the ST9000 DISCHARGE DETECTION UPGRADE, an option that provides additional functionality).

Increase reliability by measuring rise times

Display rise times for impulse waveforms as defined by standards.

Quantification of response waveforms

Test rotor assembly status

Detect single-turn faults

*Depends on measurement conditions

Improve quality by capturing accumulated turn fault data as feedback for upstream processes





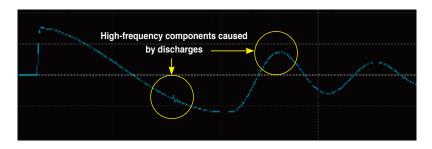
The new standard in winding testing

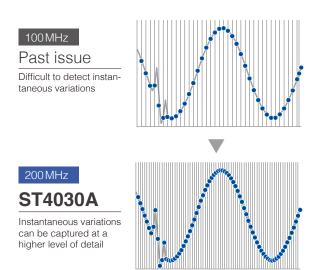
Detect defects that were impossible to detect in the past

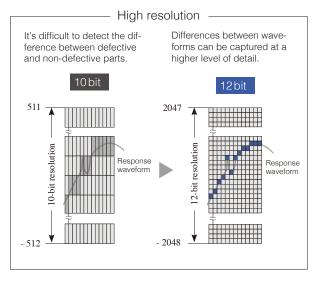


Detect minuscule changes in response waveforms

High-speed sampling × high resolution







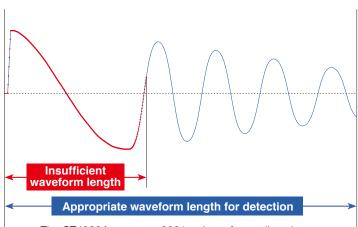


Ample sampling data for proper detection

Capture minuscule variations in response waveforms

However, since the ST4030A supports a large number of sampling points, the instrument can capture waveforms of sufficient length to support detection, even when sampling at 200 MHz.





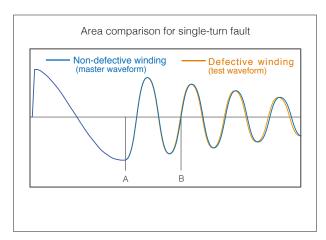
The ST4030A captures 8001 points of sampling data.

Detect single-turn faults

Quantification of response waveforms

Conventional approach

Area comparison based on waveforms

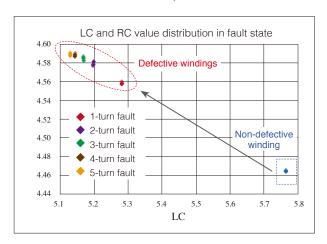


Pass/fail judgments are difficult when area differences do not exceed several percentage points.

Pass/fail judgments are made by calculating the difference in area between the master waveform and the test waveform for the interval specified by the A and B cursors.

New approach

Quantification of response waveforms



The distributions of values differ for defective and non-defective windings.

The new approach of using LC and RC values makes it possible to detect discrepancies between defective and non-defective windings, including when the differences between waveforms are too minuscule to detect using conventional means*. Since detection thresholds can be clearly defined, the instrument can give provide a clear pass/fail decision.

*See "Testable inductance range" in the specifications on the last page for more information about motors for which detection is possible. Performance may depend on conditions. Please consult with your local Hioki distributor for a test demonstration prior to purchase.

Improved applied voltage reproducibility

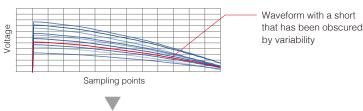
Detect defective parts with a high degree of repeatability

The ST4030A can detect defective parts with a high degree of precision thanks to low variability in the applied voltage it generates. In addition, differences between instruments when testing the same workpiece are slight, so you can continue to use master workpiece data even after one instrument is swapped out for another.

Applied voltage variability

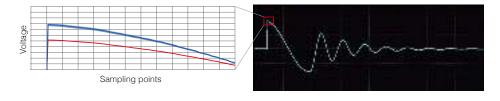
Conventional instruments

Variability in waveforms makes it difficult to detect shorts.



ST4030A

Low waveform variability allows defective windings to be detected with a high degree of precision.



Create a PASS judgment area from the distribution of LC and RC values

Full support to assist in setting testing conditions

Automatic configuration of the PASS judgment area

To make PASS and FAIL judgments, capture master LC and RC values from a known-good master workpiece.

The ST4030A will automatically create a PASS judgment area based on those values.

Choose the shape of the PASS judgment area.

HI-LO Rectangular PASS judgment area

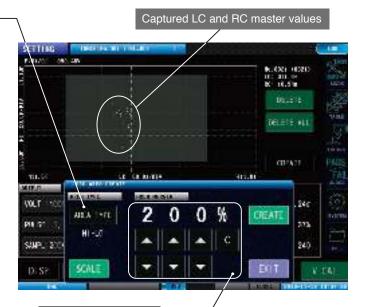


Select when the master workpiece's LC and RC values are distributed in close proximity

FIT Trapezoidal PASS judgment area



Select when the motor's rotor has been attached and the distribution of the LC and RC values assumes a belt shape according to the rotor position or angle



Set the margin

Set the margin to use when the PASS judgment area is automatically created.

CREATE

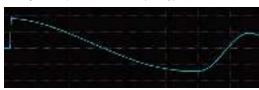
Automatically create the area by touching this button.

The created PASS judgment area will be shown as a quadrilateral on the LC/RC graph.

Automatic configuration of the waveform capture range

The oscillation frequency of response waveforms varies with the type of workpiece. To allow a sufficient amount of waveform data to be used in LC/RC value calculation and waveform judgment, the sampling frequency and sampling data count are automatically adjusted so as to optimize the waveform capture range.

Workpiece A (low oscillation frequency)



The captured waveform length is inadequate due to the response waveform's low oscillation frequency. The sampling frequency needs to be decreased.

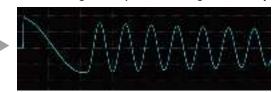
Optimizing the waveform capture range

Workpiece B (high oscillation frequency)



An unnecessary amount of waveforms is being captured due to the response waveform's high oscillation frequency. Either the sampling frequency needs to be increased, or the sampling data count needs to be decreased.

Waveform length after optimization using automatic adjustment



Optional upgrade for the ST4030A

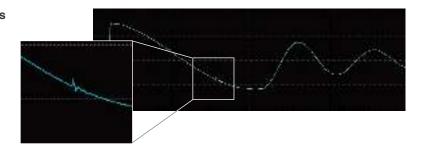
DISCHARGE DETECTION UPGRADE ST9000

Detect pseudo-shorts with a high degree of precision

By detecting minuscule partial discharges that are obscured by noise, the ST9000 makes it possible to detect insulation defects (pseudo-shorts) between motor windings.

Proprietary Hioki filtering process

Of the high-frequency components that appear in response waveforms, noise components that appear throughout the waveform are rejected so that the instrument can extract and make judgments based solely on partial discharge components.



High-precision waveform detection

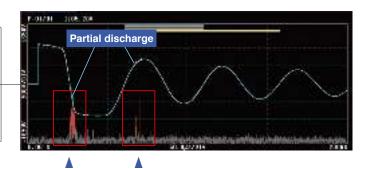
200 MHz, 12-bit sampling

Isolation of noise components

Proprietary HIOKI filter

Easy discharge detection

No need for peripheral equipment (discharge detection antenna, etc.)



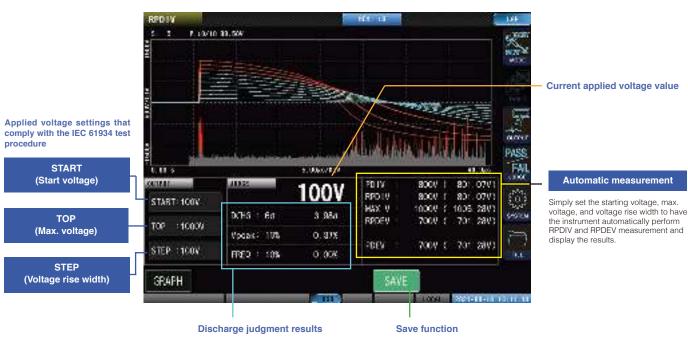
High-frequency discharge components are isolated by a proprietary Hioki filtering process.

NEW RPDIV measurement function

Automate Partial discharge measurement

For instruments equipped with the ST9000 DISCHARGE DETECTION UPGRADE (an option that provides additional functionality)

The instrument can automatically measure the partial discharge inception voltage (PDIV) and partial discharge extinction voltage (PDEV), which are required for partial discharge testing as defined by international standards for motors.



DCHG: Max. deviation of discharge amount Vpeak: Max. misalignment width from the standard peak voltage value FREQ: Max. misalignment value from

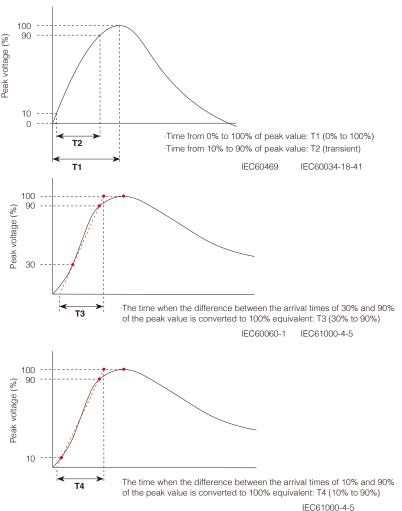
the standard vibration frequency

Test results are saved in the instrument's internal memory. Results can be saved on a USB drive or retrieved using communication commands.

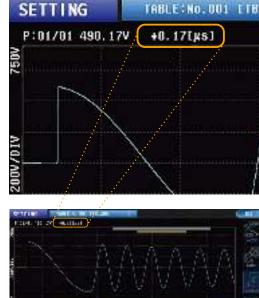
NEW Rise time measurement function

Perform reliable tests that comply with IEC standards

Impulse waveform rise times are defined by standards. With the ST4030A, you can choose from four measurement modes and display rise times for review.



Example rise time displays (with T2 selected)



Select from four measurement modes:

DELLAY

0% to 100%: T1 Transient: T2 (default) 30% to 90%: T3 10% to 90%: T4

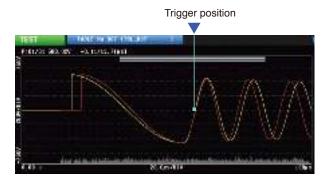
(Book)(BB)

Tinesan

NEW

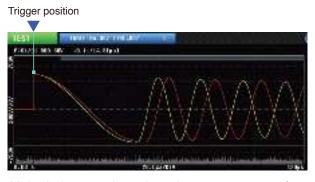
Perform tests using trigger positions based on your objective

Trigger positions that give priority to the part that shows the characteristics unique to the workpiece being tested



Make judgments based the response waveform using the second waveform, where characteristics unique to the workpiece being tested most readily appear, as the trigger.

Trigger position that priority the entire application waveform

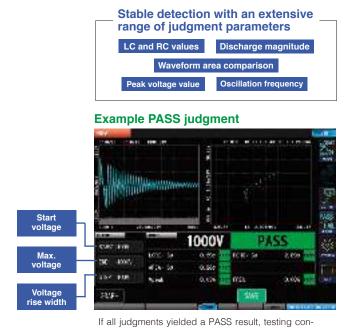


Make judgments based on the response waveform using the rising edge of the application waveform as the trigger (the same approach used by conventional testers).

Caution: Judgments based on LC and RC values are provided as reference values when using this trigger position.

Insulation breakdown voltage testing (Break Down Voltage)

The ST4030A also provides functionality for performing insulation breakdown voltage testing, which is required by various standards. An impulse test is performed while the voltage applied to the workpiece is gradually increased, and the insulation breakdown voltage is evaluated based on factors such as the response waveform's LC and RC values, the amount of discharge, and the waveform area.



tinues to the maximum voltage.

BDV setting range

Setting range: 100 V to 4200 V

Setting resolution: 10 V Number of steps: No limits

Example FAIL judgment (discharge FAIL at 2000 V)



If any of the judgments yields a FAIL result, the insulation is considered to have started to break down, and testing is halted at that point. The breakdown voltage waveform is shown in red.

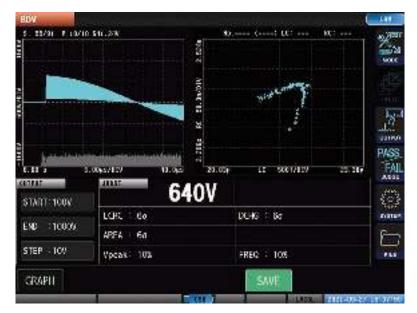
NEW

Achieve a more fine-grained BDV value measurement

The ST4030A lets you freely set the starting voltage, voltage rise width, and max. voltage without any limits on the number of steps. This capability makes it possible to perform tests with a fine-grained voltage rise width (with a minimum of 10 V steps) for any test voltage range, yielding detailed BDV value measurement results.

No limits on the number of steps (example: 91 steps)

Since there are no limits on the number of steps, even when using a small voltage rise width, you can make measurements right up to the max. voltage to obtain an accurate BDV value. (Up to 32 steps of data can be saved, using thinning as necessary.)



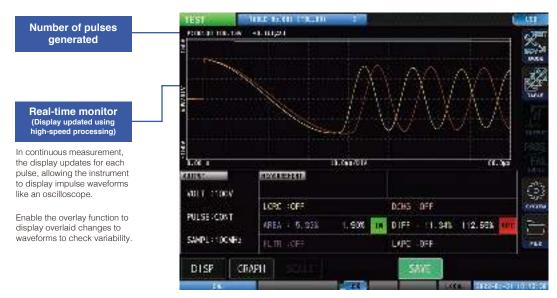
The above screenshot illustrates an example test conducted from 100 V to 1000 V using 10 V steps.

NEW

Streamline impulse durability testing and adjustment work with continuous pulse application

Streamline work by applying a pulse continuously with a single operation so that you can make adjustments while checking changes in the waveform.

Since there's no limit on the number of applied pulses, pulses are output at the specified intervals until testing is stopped.



During continuous measurement, only measurement data for the most recent pulse is maintained by the ST4030A.

NEW

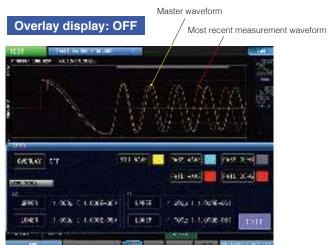
Compare and display a master waveform and the most recent measured waveform

When the overlay function is disabled, only the master waveform and most recent waveform are displayed, making it easy to view measurement results. (To generate an overlay display of waveform changes, enable the overlay function.)



To observe overlaid measurement results

If waveforms exhibit changes, for example due to the external environment, enable the overlay function so that changes in response waveforms and in LC and RC values are easier to see



To observe only the master waveform and the most recent measurement waveform

This mode is convenient to make adjustments while comparing waveforms during continuous measurement, for example while assembling stators.

Testing after rotor assembly

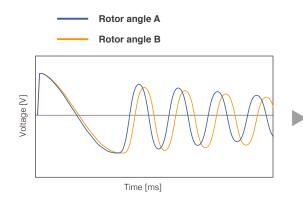


Conventional waveform detection

Clear judgment standards cannot be defined due to differences in the response waveforms depending on the position and angle at which the rotor has been attached.

Variations in the voltage waveform when the rotor is rotated (simplified illustration)

Since the waveform varies depending on the locations at which rotor angles A and B occur, it is difficult to determine a standard to use to compare the waveforms.

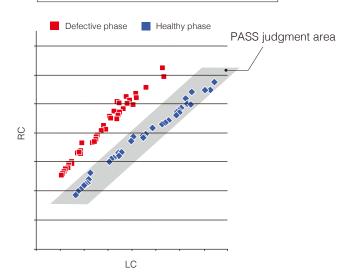


Numerical judgment using LC and RC values

If the non-defective part area is set using healthy phases, impulse testing can be performed following rotor assembly.

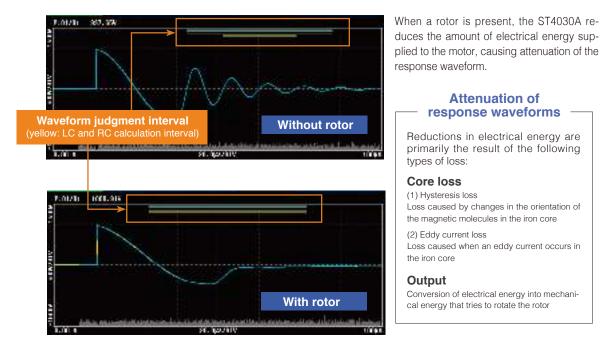
Distribution of LC and RC values when the rotor is rotated (at 50 points)

When LC and RC values are sampled while rotating the rotor, the distribution for defective phases differs from the distribution for healthy phases.



Accommodating differences in response waveform caused by motor characteristics

When testing a motor whose response waveform exhibits reduced resonance due to rotor core loss, the ST4030A automatically adjusts the judgment interval so that evaluations can be made over an interval with high voltage amplitude.

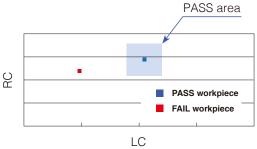


As long as the response waveforms for defective and non-defective motors differ, even if they are attenuated, the motors can be tested.

Improve parts quality by using quantified test results as feedback for upstream processes Quantitatively manage testing by quantifying response waveforms

Clarify judgment standard values

Clearly determine judgment standards based on numerical data for defective and non-defective workpieces. This information provides a basis for understanding how much the two can differ.



Use test results to manage manufacturing quality

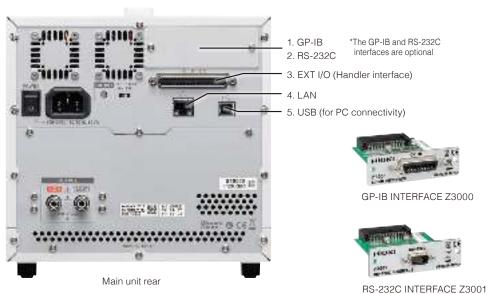
Utilize statistical quality control techniques and accumulate statistical data to estimate when winding defects will occur so as to properly take steps to prevent such issues.

Workpiece	LC[p]	RC [μ]		12 -								
1	228	4.21		12]						PASS	Sworkp	ieces
2	227	4.22		10								
3	226	4.22										
4	228	4.23	Frequency	8 -								
5	227	4.22	le	6 -								
6	226	4.21	9.									
7	227	4.23	Ĭ.	4 +		-AIL wa	rkpiec	es				
8	225	4.22		2 -								
0	219	6.51		-								
17	227	4.22		0 +	216	218	220	222	224	226	228	230
18	228	4.21			210	210	220			220	220	200
19	218	6.52						L	C[p]			
20	229	4.23										

Ideal for embedding in winding inspection systems

Space-saving Half-rack Size





Extensive range of interfaces

Interfaces

The ST4030A can be controlled from a computer using communications commands sent via its USB, LAN, GP-IB, or RS-232C interface.

LAN

Connector	RJ-45 connector
Electrical specifications	IEEE802.3 compliant
Transmission method	10BASE-T/ 100BASE-TX/ 1000BASE-T Auto detected
Protocol	TCP/IP

GP-IB (optional)

Reference standard	IEEE-488.2
Functional specifications	SH1, AH1, T6, L4, SR1, RL1, PP0, DC1, DT1, C0
Device address	0 to 30

USB (for PC connectivity)

Connector	USB Type B receptacle
Electrical specifications	USB2.0 (Full Speed/High Speed)

RS-232C (optional)

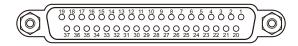
Connector	D-sub 9-pin male connector
Communication method	Full duplex
Synchronization method	Start stop synchronization
Flow control	Software (XON/XOFF control)
Transmission speed	9600,19200,38400,57600 bps

EXT. I/O

The EXT. I/O interface allows you to output signals such as the measurement complete signal (EOM) and the judgment results signal (PASS/FAIL) to an external device and to control the instrument based on input such as a START signal from an external device.

Connectors

	D- sub 37-pin		
Connectors to use (unit side)	Female connector with #4-40 inch screws		
Compliant connectors	DC-37P-ULR (solder type)		
	DCSP-JB37PR (pressure weld type)		
	Japan Aviation Electronics Industry, Ltd		



Input signals

Pin	Pin name	Description
1	START	The instrument starts testing at the START signal's ON edge.
20	STOP	The instrument stops testing when it detects the ON edge of the STOP signal during testing.
3	INTERLOCK	If the instrument's interlock setting is enabled, the interlock state is canceled while the INTER-LOCK signal is ON.
4 to 7, 22 to 25	TBL0 to 7	Selects the table number in which switchable test conditions have been saved.

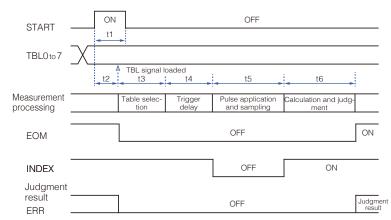
Output signals

	4 3					
Pin	Pin name	Description				
29	INDEX	Indicates that analog measurement (pulse application and sampling) has ended. When this signal changes from OFF to ON, the probes can be placed in the open state.				
28	EOM	This signal is output when testing is complete. The judgment results and ERR signals are refreshed once the EOM signal is output.				
10	ERR	This signal is output when a measurement error such as an open error or hardware error occurs.				
18	PASS	This signal is output when the overall judgment result is PASS.				
37	FAIL	This signal is output when the overall judgment result is FAIL.				
11 to 13 30 to 32	OUT_XXX	These signals are output when a judgment function generates an OUT judgment.				
16, 17,35	OUT0 to 2	These signals can be used as general-purpose output. The output signal can be controlled using the :IO:OUTPut command.				

Insulated power source output

Pin	Din nome	NPN/PNP switch settings				
1 111	Pin name	NPN	PNP			
8	ISO_5V	Insulated power source +5 V	Insulated power source -5 V			
9, 27	ISO_COM	Insulated power source common	Insulated power source common			

Example of measurement timing



Item	Description	time
t1	START signal ON time	1 ms or greater
t2	Trigger detection time	1 ms (typical value)
		10ms (typical value)
t3	Table selection time	*Add the internal discharge time if the test voltage for the table after switching is less than the test voltage before switching.
t4	Trigger delay time	0.000s to 9.999s
t5	Analog measurement time	50 ms (typical value for a set voltage of 3000 V, sampling frequency of 200 MHz, and 1 pulse application)
t6	Calculation and judgment time	15ms (typical value when the AREA, DIFF, FLUTTER, or LAPLACIAN judgment function is enabled) *When applying multiple pulses, indicates the judgment and calculation times for the final pulse.

Test times (reference values)

(EOM)	EOM = (INDEX + software processing time + judgment times × number of pulses applied *Degaussing pulses do not entail software processing time or judgment time. *When applying multiple pulses, the testing process is controlled so that each pulse application interval is not less than the minimum pulse application interval set time.						it time. at each
Analog measure- ment times	Time through cha						
(INDEX)	Set voltage	100 V	1000) V	2000 V	3000 V	
, ,	INDEX time	30 ms	30 m	ns	40 ms	50 ms	
Software processing time	Software processing time covering data transfers, etc.(typical value), Processing time: 10 ms *S/s: 200 MHz, DISP: THIN						
Judgment time	Processing time when each judgment function is enabled (typical value)				e)		
	Judgment	Processir	ng time				
	AREA*1	1 m	s				
	DIFF*1	1 m	s				
	FLTR*1	1 m	1 ms		amont area: 1	500 pt	
	LAPC*1	1m	s	*1 Judgment area: 1500 pt *2 Calculation interval: 1500 pt			
	LC·RC*2	100 ms		*3 Judgment interval with sampling speed			
DISCHARGE*3 75ms of 2		of 200 MHz: 8001 pt					

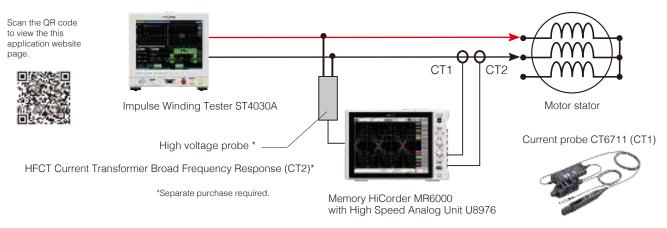
Electrical specifications

	Input type	Photocoupler-isolated non-voltage contact input (with current sink/source output support)
Input signals	Input ON	Residual voltage of 1 V or less; input ON current of 4 mA (reference values)
	Input OFF	OPEN (breaking current of 100 μA or less)
	Output type	Photocoupler-isolated open-drain output (non-polar)
Output signals	Maximum load voltage	DC 30 V
Output signals	Maximum load current	50 mA/ch
	Residual voltage	1 V or less (load current of 50 mA) / 0.5 V or less (load current of 10 mA)
	Output voltage	Sink output support: +5.0 V ±0.8V; source output support: -5.0 V ±0.8 V
nternally isolated power supply	Maximum output current	100 mA
	Insulation	Floating from protective ground potential and measurement circuit
	Insulation rating	Terminal-to-ground voltage of 50 V DC, 30 V AC rms, 42.4 V AC peak or less

Applications

Partial Discharge Testing of Motor Stators Using an Impulse Tester and Memory HiCorder

It's possible to check for insulation defects in motor stators by observing current waveforms during impulse testing.



Measured data

Video of measured

- · The current waveforms did not exhibit significant disturbances at a test voltage of 2000 Vpeak.
- · A significant disturbance resembling a pulsating current was observed at a test voltage of 2600 Vpeak. That disturbance indicates a partial discharge.

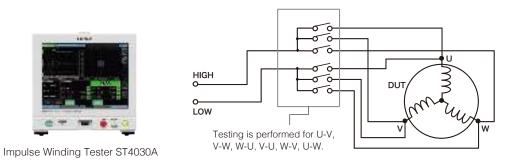
Automatic impulse testing of motor stators using high-voltage relays

In the case of a 3-phase stator, impulse tests are carried out between each phase combination: U-V, V-W, W-U, V-U, W-V, and U-W.

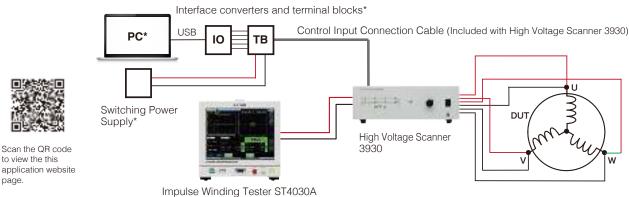
Consequently, manufacturers work to automate such tests by using relays to switch test circuits.

However, when test voltages exceed 1500 V, it becomes impossible to use standard relays.

As a result, impulse testing between stator phases is carried out by means of manual measurement or manual switches.



Automate testing using a setup such as the one shown below by using a High Voltage Scanner 3930 to switch the measurement circuit. *Separate purchase required.





Scan the QR code to view the this application website

Specifications (Accuracy guaranteed for 1 year)

Applied voltage	100 V to 4200 V (resolution set in 10 V steps)	
Testable inductance range	10 µH to 100 mH	
Sampling speed	200 MHz / 100 MHz / 50 MHz / 20 MHz /10 MHz	
Sampling resolution	12 bit	
Voltage detection accuracy	DC accuracy: ±5% of setting, AC band: 100 kHz, ±1 dB Accuracy guarantee conditions: 23°C ±5°C, 80% RH or less	
Number of samples	1001 to 8001 points (set in 1000 point steps)	
Judgment method	The same impulse voltage is applied to a master workpiece and the workpiece under test, and a PASS/FAIL judgment is made by comparing the shapes, LC and RC values, and discharge component magnitudes of the respective response waveforms.	
	LC/RC value judg- ment	LC/RC value judgment (LCRC AREA)
	Waveform judgment	Waveform area comparison judgment (AREA) Waveform differential area comparison judgment (DIFF-AREA) Waveform flutter detection judgment (FLUTTER) Waveform second derivative detection judgment (LAPLACIAN)
	Discharge detection (With ST9000)	Discharge detection (DISCHARGE)
Insulation breakdown voltage testing mode	The workpiece is subjected to impulse testing while gradually raising the applied voltage to determine the voltage at which the insulation breaks down. Waveform area judgment, discharge judgment, and LC/RC value judgment are used to judge insulation breakdown.	
Discharge starting voltage testing (with ST9000 Discharge Detection Upgrade)	Checks for discharge generation by performing impulse testing through applying voltages in accordance with the procedure defined by IEC 61934.	
Number of test condition tables	255 (test condition settings, detection condition settings, master waveforms)	
Test duration	Approx. 60 ms (reference value when tester is configured for 3000 V, 1 pulse, detection off)	
Display	Touch screen display: 8.4-inch SVGA color TFT LCD (800 × 600 dots) Functionality for changing the background color: 4 colors available	
Safety functionality	Key lock, interlock, double-action design (to prevent erroneous operation when starting testing)	

*Maximum applied energy: Approx. 88 mJ

General specifications

Operating environment	Use indoors at an elevation of 2,000 m or less in an environment with a maximum pollution level of 2	
Operating temperature and humidity range	0°C to 40°C (32°F to 104°F), 80% RH or less (no condensation)	
Storage temperature and humidity	-10°C to 50°C (14°F to 122°F), 80% RH or less (no condensation)	
Standards compliance	Safety: EN 61010, EMC: EN 61326 Class A	
Power supply	AC100 V to 240V, 50 Hz/60 Hz	
External interface	Standard equipment: EXT. I/O, USB host (memory stick), USB device (for communications), LAN Options: RS-232C (Z3001), GP-IB (Z3000)	
Dimensions	Approx. 215 mm (8.46 in) W × 200 mm (7.87 in) H × 348 mm (13.7 in) D (excluding protrusions)	
Mass	Approx. 6.7 kg (236.3 oz)	
Accessories	Power cord, instruction manual, application disc, operating precautions	

Model: IMPULSE WINDING TESTER ST4030A

Model No. (Order Code)

ST4030A

Additional function options

DISCHARGE DETECTION UPGRADE ST9000

The Discharge Detection Upgrade ST9000 is a factory option for the Impulse Winding Tester ST4030A. Please specify at the time of order.

Options

CLIP TYPE LEAD L2250 Maximum rated voltage: 3300 V AC peak, 1.5 m (4.92 ft) length

UNPROCESSED LEAD CABLE L2252 Maximum rated voltage: 4200 V AC peak, 2 m (6.56 ft) length



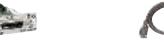
Caution: Effect of cable parasitic components

The oscillation waveform varies with the length of the cable. Please contact your Hioki distributor concerning availability of special-order cables whose capacitance values fall within the acceptable range.



GP-IB INTERFACE Z3000

GP-IB CONNECTOR CABLE 9151-02 2 m (6.56 ft) length



RS-232C INTERFACE Z3001



RS-232C CONNECTOR CABLE 9637 9 pin - 9 pin, cross, 1.8 m (5.91 ft) length





Note: Company names and product names appearing in this catalog are trademarks or registered trademarks of various companies.

DISTRIBUTED BY

HEADQUARTERS 81 Koizumi, Ueda, Nagano 386-1192 Japan https://www.hioki.com/

